

**Notice of References Cited**Application/Control No.  
**10/058,715**Applicant(s)/Patent Under Reexam  
**Singhal et al.**Examiner  
**Cam Nguyen**Art Unit  
**1754**

Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	6,365,301 B1	4/2002	Michot et al.	429	307
B	4,026,811	5/1977	Readey et al.	252	63.2
C	6,436,577 B1	8/2002	Kida et al.	429	231.95
D	6,475,673 B1	11/2002	Yamawaki et al.	429	231.5
E	6,379,843 B1	4/2002	Yamasaki et al.	429	231.5
F	4,649,037	3/1987	Marsh et al.	423	338
G	4,567,031	1/1986	Riley	423	593
H	6,319,421 B1	11/2001	Yun et al.	252	62.9 R
I	6,294,011 B1	9/2001	Hedouin et al.	106	439
J					
K					
L					
M					

**FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N						
O						
P						
Q						
R						
S						
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**NON-PATENT DOCUMENTS**

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